

# Search Notes



Application/Control No.

10/670,154

Examiner

Mark K. Han

Applicant(s)/Patent under Reexamination

TROCKI ET AL.

Art Unit

3767

## SEARCHED

Class	Subclass	Date	Examiner
604	93.01 118	10/1/2006	mbh.
	121 131		
	151 152		
	154 181		
	187 500		
	507 508		
	533 534		
	535		
600	431		
	432		
128	898		
	dig. 1		
	dig. 12		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text search	10/1/2006	mbh.